

# 1-Bit Compressed Sensing Of Positive Semi-Definite Matrices Via Rank-1 Measurement Matrices

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## 1-bit Compressed Sensing (CS) of Positive Semi-definite (PSD) Matrix

- ▶ Frugal sensing (Mehanna and Sidiropoulos 2013): 1-bit sensing of Toeplitz PSD matrix for spectral estimation and parameter estimation.
- ▶ 1-bit sensing of covariance matrix for principle subspace estimation and online line spectrum estimation (Chi 2014a,b).
- ▶ Our work: propose 1-bit CS of PSD matrix via rank-1 measurement matrix and provide more accurate recovery error bound.

## Measuring via Rank-1 Matrix

- ▶  $n \times n$  rank- $r$  PSD matrix  $\Sigma = \mathbf{Q}\Lambda\mathbf{Q}^T$ :
  - ▷  $n \times n$  orthogonal matrix  $\mathbf{Q}$ .
  - ▷  $n \times n$  diagonal matrix  $\Lambda = \text{diag}\{\lambda_1, \dots, \lambda_n\}$  with  $\lambda_1 \geq \dots \geq \lambda_r > \lambda_{r+1} = \dots = \lambda_n = 0$ .
  - ▷ Normalized norm:  $\|\Sigma\|_F^2 = \sum_{i=1}^n \lambda_i^2 = 1$ .
  - ▷ Condition number  $\kappa = \lambda_1/\lambda_r \leq \infty$ .
- ▶ Rank-1 measurement matrix  $\mathbf{W}_k = \mathbf{a}_k\mathbf{b}_k^T$  with independent  $\mathbf{a}_k$  and  $\mathbf{b}_k \sim \mathcal{N}(\mathbf{0}, \mathbf{I}_n)$ .
- ▶  $m$  measured bits  $y_k \in \{+1, -1\}$  ( $k = 1, \dots, m$ ) satisfy (Plan and Vershynin 2013)
 
$$\mathbb{E}[y_k | \mathbf{W}_k, \Sigma] = \theta(\langle \mathbf{W}_k, \Sigma \rangle) = \theta(\mathbf{a}_k^T \Sigma \mathbf{b}_k),$$
- ▶ For error-free measurement  $\theta(\cdot) = \text{sign}(\cdot)$ .

## Equivalence Between Rank-1 Measurement and Quadratic Measurement

- ▶ Quadratic measurement (Chi 2014a,b):
  - ▷ Measurement matrix  $\tilde{\mathbf{W}}_k = (\tilde{\mathbf{a}}_k\tilde{\mathbf{a}}_k^T - \tilde{\mathbf{b}}_k\tilde{\mathbf{b}}_k^T)/2$  with independent  $\tilde{\mathbf{a}}_k$  and  $\tilde{\mathbf{b}}_k \sim \mathcal{N}(\mathbf{0}, \mathbf{I}_n)$ .
  - ▷ Measured bit  $y_k$  satisfies  $\mathbb{E}[y_k | \tilde{\mathbf{W}}_k, \Sigma] = \theta(\langle \tilde{\mathbf{W}}_k, \Sigma \rangle) = \theta((\tilde{\mathbf{a}}_k^T \Sigma \tilde{\mathbf{a}}_k - \tilde{\mathbf{b}}_k^T \Sigma \tilde{\mathbf{b}}_k)/2)$
- ▶ Equivalence:  $\tilde{\mathbf{a}}_k = \frac{1}{\sqrt{2}}(\mathbf{a}_k + \mathbf{b}_k)$ ,  $\tilde{\mathbf{b}}_k = \frac{1}{\sqrt{2}}(\mathbf{a}_k - \mathbf{b}_k) \Rightarrow \tilde{\mathbf{W}}_k = (\mathbf{W}_k + \mathbf{W}_k^T)/2 \Rightarrow \langle \tilde{\mathbf{W}}_k, \Sigma \rangle = \langle \mathbf{W}_k, \Sigma \rangle$ .

## The PSD Recovery Problem (Penalized Trace Minimization)

$$\max_{\mathbf{X}} -\text{tr}(\mathbf{X}\mathbf{S}_m) + \gamma \text{tr}(\mathbf{X}), \text{ s.t. } \mathbf{X} \succeq 0, \|\mathbf{X}\|_F \leq 1,$$

- ▶ The empirical mean  $\mathbf{S}_m = \frac{1}{2m} \sum_{k=1}^m y_k(\mathbf{W}_k + \mathbf{W}_k^T) = \mathbf{U}\mathbf{T}\mathbf{U}^T$  with orthogonal matrix  $\mathbf{U}$  and diagonal matrix  $\mathbf{T}$ .
- ▶ The closed-form solution

$$\hat{\mathbf{X}} = \begin{cases} \frac{1}{\|\mathcal{D}_\gamma(\mathbf{S}_m)\|_F} \mathcal{D}_\gamma(\mathbf{S}_m), & \text{if } \|\mathbf{S}_m\| > \gamma, \\ 0, & \text{otherwise,} \end{cases}$$

$\mathcal{D}_\gamma(\mathbf{S}_m) = \mathbf{U}(\mathbf{T} - \gamma \mathbf{I}_n)^+ \mathbf{U}^T$  is the singular value thresholding operator.

## Lemma 1 (Eigendecomposition of mean $\mathbf{S} = \mathbb{E}[y_k \mathbf{W}_k]$ )

$$\mathbf{S} = \mathbf{Q}\mathbf{D}\mathbf{Q}^T$$

- ▶  $\mathbf{D} = \text{diag}\{\sigma_1, \dots, \sigma_r, 0, \dots, 0\}$  with  $\sigma_i = \lambda_i \delta_i$ .
- ▶  $\delta_i = \mathbb{E}\left[\frac{\lambda(\mathbf{z}^T \Lambda^2 \mathbf{z})}{\mathbf{z}^T \Lambda^2 \mathbf{z}} z_i^2\right]$ ,  $\delta_i = \sqrt{\frac{2}{\pi}} \mathbb{E}\left[\frac{z_i^2}{\sqrt{\mathbf{z}^T \Lambda^2 \mathbf{z}}}\right]$  (the error-free case)
- ▶ where  $\mathbf{z} = [z_1, \dots, z_n]^T \sim \mathcal{N}(\mathbf{0}, \mathbf{I}_n)$ .

## Interlude: Bound for Eigenvalues of $\mathbf{S}$

- ▶ Proposition 1:  $\frac{2}{\pi} \geq \sigma_i \geq \frac{2}{\sqrt{\pi\kappa r}} \frac{\Gamma(\frac{r+1}{2})}{\Gamma(\frac{r}{2})}$ ,  $i = 1, \dots, r$ .
- ▶ Asymptotic lower bound:  $\lim_{r \rightarrow \infty} \frac{2}{\sqrt{\pi\kappa r}} \frac{\Gamma(\frac{r+1}{2})}{\Gamma(\frac{r}{2})} = \frac{\sqrt{2}}{\kappa\sqrt{\pi}} \frac{1}{\sqrt{r}}$ .

## Useful Bounds for Recovery Error Analysis (Error-free Measurement)

- ▶ Error in mean (Lemma 2 of (Chi 2014b)):  $\|\mathbf{S}_m - \mathbf{S}\|_F \leq \sqrt{\frac{C_1 n \log \frac{2n}{\delta}}{m}}$  with probability at least  $1 - \delta$
- ▶ Error between  $\bar{\mathbf{S}} = \mathbf{S}/\|\mathbf{S}\|_F$  and  $\Sigma$  (Lemma 3):  $\|\bar{\mathbf{S}} - \Sigma\|_F = \sqrt{\sum_{i=1}^r \lambda_i^2 (\rho \delta_i - 1)^2} \leq \frac{C_2 \kappa^{10}}{r}$  for  $r > 5\kappa^5$  where  $\rho = 1/\|\mathbf{S}\|_F$
- ▶ Deviation of non-zero  $\delta_i$  from 1 (Lemma 4):  $|\delta_i - 1| \leq \frac{5\kappa^5}{r}$

## Theorem 1 (Recovery Error Bound for Error-free Measurement)

If the regularization parameter

$$\gamma = 2\sqrt{\frac{C_1 n \log(2n/\delta)}{m}}$$

with probability at least  $1 - \delta$ , we have for  $r > 5\kappa^5$  the following bound on recovery error:

$$\|\hat{\mathbf{X}} - \Sigma\|_F \leq 3\sqrt{\frac{C_1 n r \log(2n/\delta)}{m}} + \frac{C_2 \kappa^{10}}{r}.$$

Proof idea: triangular inequality  $\|\hat{\mathbf{X}} - \Sigma\|_F \leq \|\hat{\mathbf{X}} - \bar{\mathbf{S}}\|_F + \|\bar{\mathbf{S}} - \Sigma\|_F$ .

- ▶ The first error term: proof idea of Theorem 1 in (Zhang, Yi, and Jin 2014) with the aid of Lemma 2 and the decomposition of tangent and normal spaces at  $\Sigma$  (Candès and Recht 2009).
- ▶ The second error term: Lemma 3.

## Numerical Results

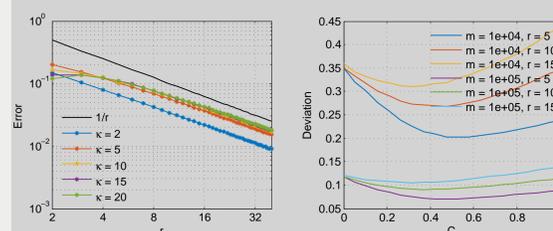


Figure 1:  $\mathbb{E}[\|\bar{\mathbf{S}} - \Sigma\|_F]$  versus  $r$ .

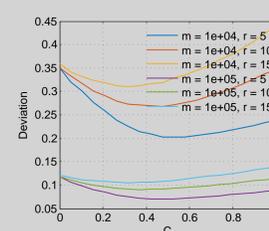


Figure 2:  $\mathbb{E}[\|\hat{\mathbf{X}} - \bar{\mathbf{S}}\|_F]$  versus  $C$ . ( $C^{\text{opt}} \approx 0.5$ )

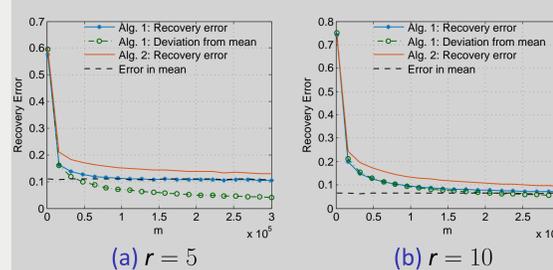


Figure 3: Recovery error versus  $m$ .

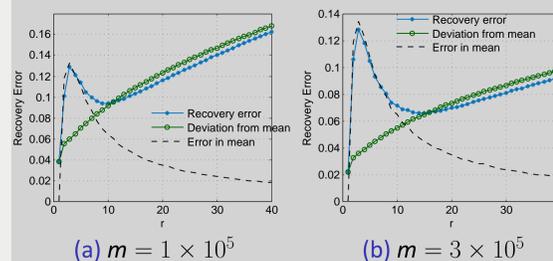


Figure 4: Recovery error versus  $r$ .

## Setup:

- ▷ 1000 trials.
- ▷ Dimension  $n = 50$ .
- ▷ Eigenvector:  $\text{orth}(\mathbf{X})$  with  $\mathbf{X} = [x_{ij}] \in \mathbb{R}^{50 \times r}$  and  $x_{ij} \sim \mathcal{N}(0, 1)$ .
- ▷ Non-zero eigenvalues:  $\lambda_i = \tilde{\lambda}_i / \sum_{i=1}^r \tilde{\lambda}_i$  with  $\tilde{\lambda}_1 = \kappa$ ,  $\tilde{\lambda}_r = 1$ , and  $\tilde{\lambda}_i \sim \mathcal{U}[1, \kappa]$ .
- ▷  $\gamma = C\sqrt{n \log(n)/m}$ .

## Algorithm 2:

$$\max_{\mathbf{X} \succeq 0, \|\mathbf{X}\|_F=1, \|\mathbf{X}\|_* \leq \sqrt{r}} \text{tr}(\mathbf{X}\mathbf{S}_m).$$

- ▶ Performance metrics:
  - ▷ Recovery error  $\|\hat{\mathbf{X}} - \Sigma\|_F$ .
  - ▷ Error in mean  $\|\bar{\mathbf{S}} - \Sigma\|_F$ .
  - ▷ Deviation form mean  $\|\hat{\mathbf{X}} - \bar{\mathbf{S}}\|_F$ .

## Conclusion

- ▶ Closed-form solution for PSD matrix recovery problem and more accurate error bound can be obtained with the proposed rank-1 measurement scheme.
- ▶ Both analysis and simulation reveal that the recovery is biased but the minimum recovery error is achieved at certainty  $r$ .
- ▶ Extend the analysis to the case of the noisy measurement and structured PSD matrix (e.g., Toeplitz matrix) recovery in further research.

## References

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